

Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = -250\text{ }\mu\text{A}$, $V_{GS} = 0\text{ V}$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$, referenced to $25\text{ }^\circ\text{C}$		-23		mV/ $^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24\text{ V}$, $V_{GS} = 0\text{ V}$			-1	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 8\text{ V}$, $V_{DS} = 0\text{ V}$			± 1	μA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = -250\text{ }\mu\text{A}$	-0.4	-0.6	-1	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$, referenced to $25\text{ }^\circ\text{C}$		2.4		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -4.5\text{ V}$, $I_D = -2.9\text{ A}$		67	90	m Ω
		$V_{GS} = -2.5\text{ V}$, $I_D = -2.6\text{ A}$		81	130	
		$V_{GS} = -1.8\text{ V}$, $I_D = -1.7\text{ A}$		98	170	
		$V_{GS} = -1.5\text{ V}$, $I_D = -1\text{ A}$		114	240	
		$V_{GS} = -4.5\text{ V}$, $I_D = -2.9\text{ A}$, $T_J = 125\text{ }^\circ\text{C}$		102	133	
g_{FS}	Forward Transconductance	$V_{DS} = -5\text{ V}$, $I_D = -2.9\text{ A}$		11		S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = -15\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$		438	580	pF
C_{oss}	Output Capacitance			47	70	pF
C_{rss}	Reverse Transfer Capacitance			41	60	pF

Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -15\text{ V}$, $I_D = -1\text{ A}$, $V_{GS} = -4.5\text{ V}$, $R_{GEN} = 6\text{ }\Omega$		4.8	10	ns
t_r	Rise Time			4.4	10	ns
$t_{d(off)}$	Turn-Off Delay Time			67	107	ns
t_f	Fall Time			21	33	ns
Q_g	Total Gate Charge	$V_{DD} = -15\text{ V}$, $I_D = -2.9\text{ A}$, $V_{GS} = -4.5\text{ V}$		7.2	10	nC
Q_{gs}	Gate to Source Charge			0.7		nC
Q_{gd}	Gate to Drain "Miller" Charge			1.6		nC

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}$, $I_S = -1.1\text{ A}$ (Note 2)		-0.7	-1.2	V
t_{rr}	Reverse Recovery Time	$I_F = -2.9\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$		16	29	ns
Q_{rr}	Reverse Recovery Charge			5	10	nC

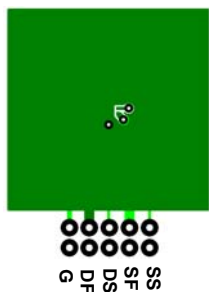
BJT Characteristics

I_{CBO}	Collector Cut-off Current	$V_{CB} = 40\text{ V}$, $I_E = 0\text{ A}$			0.1	μA
h_{FE}	DC Current Gain	$V_{CE} = 5\text{ V}$, $I_C = 5\text{ mA}$	68			
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 10\text{ mA}$, $I_B = 0.5\text{ mA}$			0.3	V
f_T	Current Gain Bandwidth Product	$V_{CE} = 10\text{ V}$, $I_C = 5\text{ mA}$		250		MHz
C_{ob}	Output Capacitance	$V_{CB} = 10\text{ V}$, $I_E = 0\text{ A}$, $f = 1\text{ MHz}$		3.7		pF
$V_{I(off)}$	Input Off Voltage	$V_{CE} = 5\text{ V}$, $I_C = 100\text{ }\mu\text{A}$	0.5			V
$V_{I(on)}$	Input On Voltage	$V_{CE} = 0.2\text{ V}$, $I_C = 5\text{ mA}$			1.3	V
R1	Input Resistor			4.7		k Ω
R1/R2	Resistor Ratio			0.1		

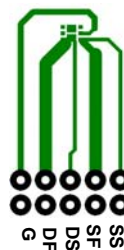
Electrical Characteristics

Notes:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.



a. 86 °C/W when mounted on
a 1 in² pad of 2 oz copper



b. 173 °C/W when mounted on
a minimum pad of 2 oz copper

2. Pulse Test : Pulse Width < 300 us, Duty Cycle < 2.0%
3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.
4. Guaranteed by I_{CBO}
5. Guaranteed by I_{CEO}

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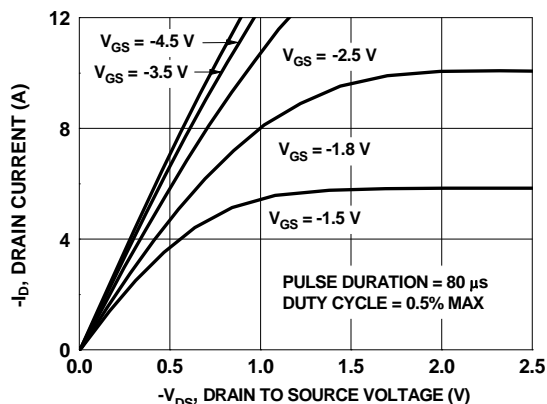


Figure 1. On-Region Characteristics

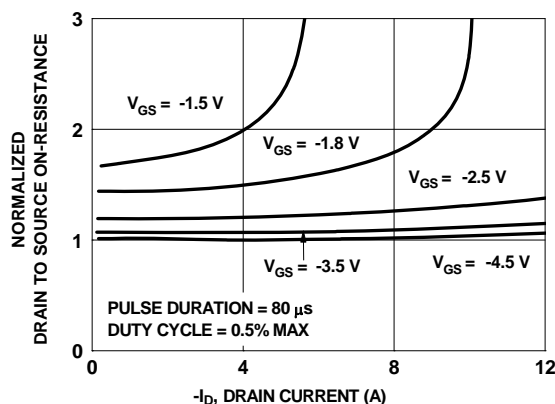


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

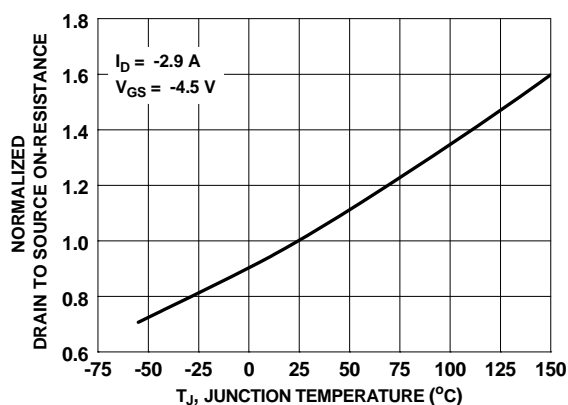


Figure 3. Normalized On-Resistance vs Junction Temperature

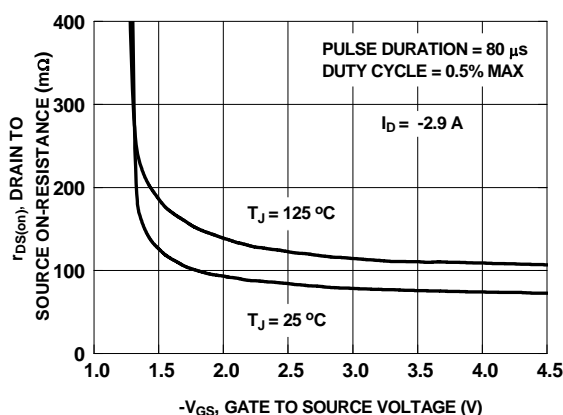


Figure 4. On-Resistance vs Gate to Source Voltage

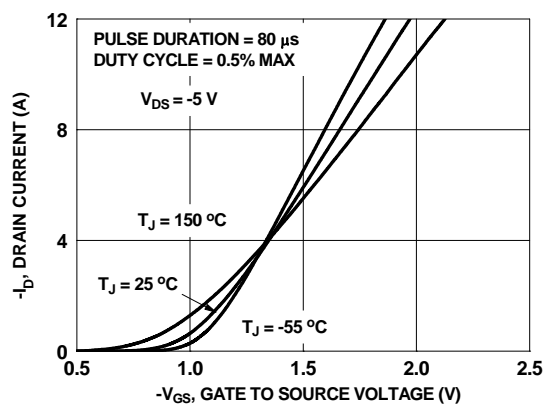


Figure 5. Transfer Characteristics

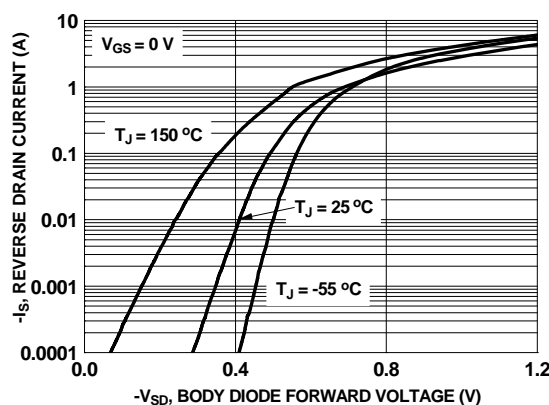


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

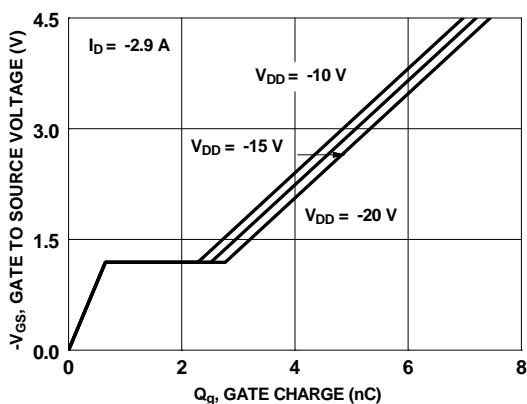


Figure 7. Gate Charge Characteristics

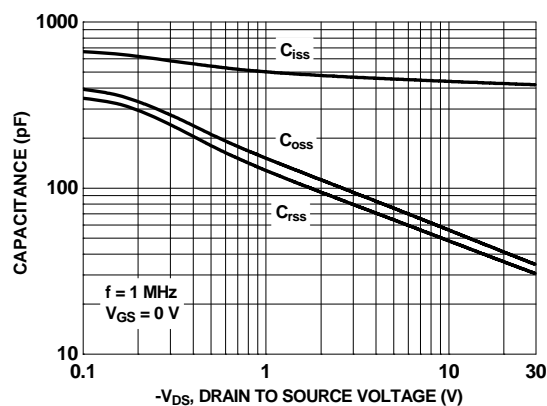


Figure 8. Capacitance vs Drain to Source Voltage

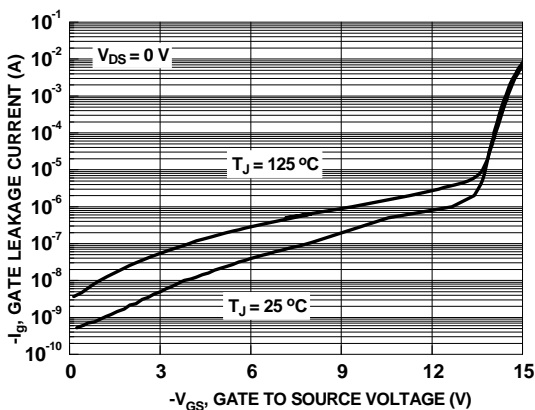


Figure 9. Gate Leakage vs Gate to Source Voltage

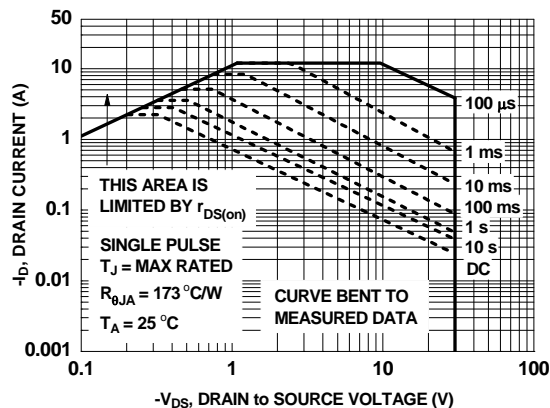


Figure 10. Forward Bias Safe Operating Area

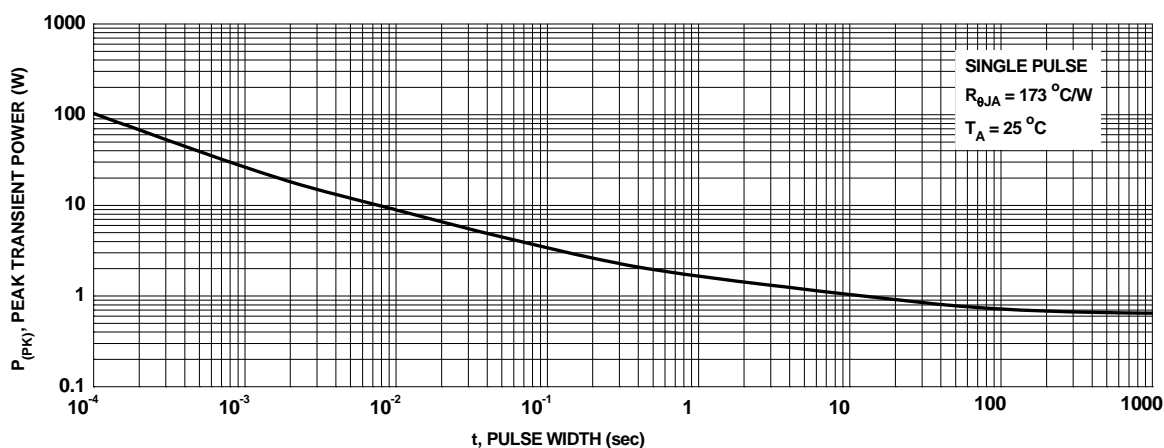


Figure 11. Single Pulse Maximum Power Dissipation

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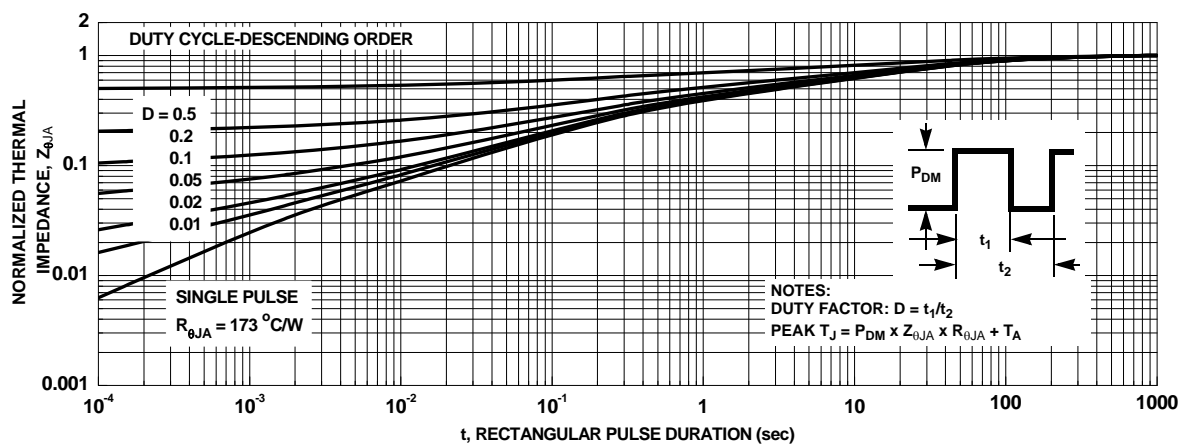
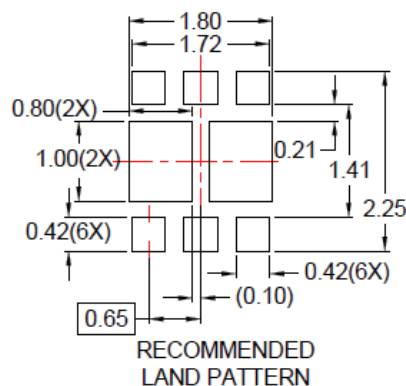
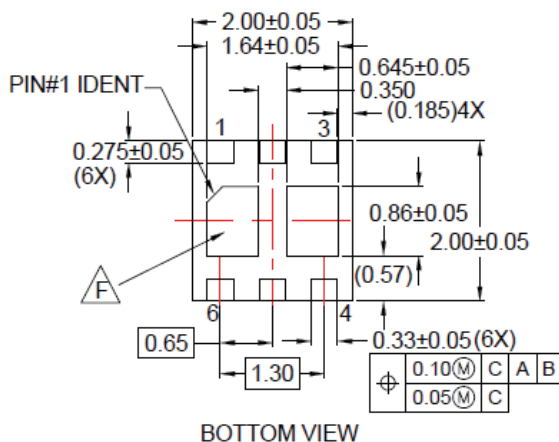
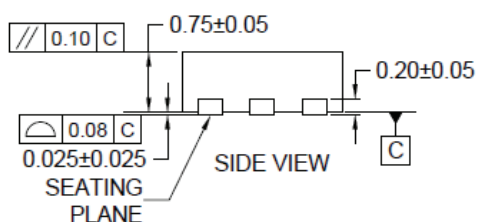
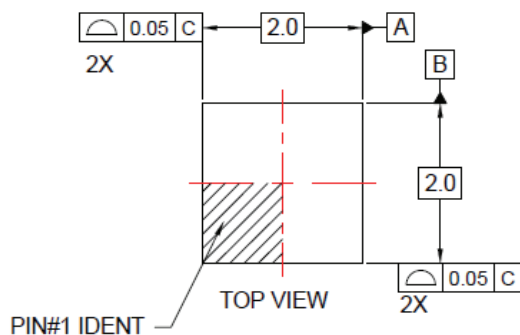


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout



NOTES:

- CONFORM TO JEDEC REGISTRATIONS MO-229, VARIATION VCCC, EXCEPT WHERE NOTED.
 - DIMENSIONS ARE IN MILLIMETERS.
 - DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
 - LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
 - DRAWING FILENAME: MKT-UMLP16Erev4
- △ F: NON-JEDEC DUAL DAP



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